	Search Notes				

Application/Control No.	Applicant(s)/Patent u Reexamination	ınder
10/639,587	OKUNO, TOSHIAKI	
Examiner	Art Unit	
Nothan Cura	2612	

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Class	Subclass	Date	Examiner
39.8	81 147- 150,159	8/30/06	ne
398	81,147-150, 159	3/26/07	ne
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INTERFERENCE SEARCHED		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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DAST Keyword search (see printent)	8/2406 4/30/06 9(1/06	mc nc nc	
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